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			GUILL, RUSSELL L	
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)				
	10/786,315	IWAKURA ET AL.				
Office Action Summary	Examiner	Art Unit				
	Russ Guill	2123				
The MAILING DATE of this communication a Period for Reply	ppears on the cover sheet with	the correspondence address				
A SHORTENED STATUTORY PERIOD FOR REF WHICHEVER IS LONGER, FROM THE MAILING - Extensions of time may be available under the provisions of 37 CFR after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory perion for reply within the set or extended period for reply will, by state Any reply received by the Office later than three months after the main earned patent term adjustment. See 37 CFR 1.704(b).	DATE OF THIS COMMUNICA 1.136(a). In no event, however, may a repl of will apply and will expire SIX (6) MONTH ute, cause the application to become ABAN	ATION. ly be timely filed IS from the mailing date of this communication. NDONED (35 U.S.C. § 133).				
Status						
)⊠ Responsive to communication(s) filed on <u>26 February 2004</u> .						
2a)☐ This action is FINAL . 2b)⊠ Th	This action is FINAL . 2b)⊠ This action is non-final.					
	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims						
4) ⊠ Claim(s) 1-38 is/are pending in the application 4a) Of the above claim(s) is/are withden 5) □ Claim(s) is/are allowed. 6) ⊠ Claim(s) 1-38 is/are rejected. 7) □ Claim(s) is/are objected to. 8) □ Claim(s) are subject to restriction and	rawn from consideration.					
Application Papers	,					
9) The specification is objected to by the Exami 10) The drawing(s) filed on 26 February 2004 is/s Applicant may not request that any objection to the Replacement drawing sheet(s) including the correction. The oath or declaration is objected to by the	are: a)⊠ accepted or b)⊡ ob ne drawing(s) be held in abeyance ection is required if the drawing(s)	e. See 37 CFR 1.85(a). is objected to. See 37 CFR 1.121(d).				
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received.						
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date 2/26/2004.		nmary (PTO-413) Mail Date ormal Patent Application				

Art Unit: 2123

DETAILED ACTION

1. Claims 1 – 38 have been examined. Claims 1 – 38 have been rejected.

Claim Rejections - 35 USC § 112

2. The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

- a. Claims 8 10, 24 26 and 35 37 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.
 - i. Regarding claims 8, 24 and 35, the claims recite, "said elements mounted". The term appears to have insufficient antecedent support. The antecedent elements do not appear to be mounted. For the purpose of claim examination, the phrase is interpreted as "said elements". Correction or amendment is required.
 - ii. Claims 9 10, 25 26 and 36 37 are rejected based on their dependency on their respective intermediate and parent claims which are rejected under 35 U.S.C. 112, second paragraph.

Claim Rejections - 35 USC § 101

3. 35 U.S.C. 101 reads as follows:

Whoever invents or discovers any new and useful process, machine, manufacture, or composition of matter, or any new and useful improvement thereof, may obtain a patent therefor, subject to the conditions and requirements of this title.

4. Claims 1 – 16, 17, 28 – 37 and 38 rejected under 35 U.S.C. 101 because the claimed invention is directed to non-statutory subject matter.

Page 2

allow any functionality to be realized.

Art Unit: 2123

a. Regarding independent claims 1 and 17, and dependent claims, the claim is directed to a power supply noise analysis model generator. The limitations of the power supply noise analysis model generator appear to allow an interpretation that is entirely software. The processing sections claimed in the limitations appear to be entirely software. Further, the claim does not appear to have a processor that is functionally connected to the processing sections to

Page 3

b. Regarding independent claims 28 and 38, and dependent claims, the claim is directed to a power supply noise analysis model generator program. The preamble allows an interpretation that the program is source code, which is non-functional descriptive material, and is therefore non-statutory. If a claim can be interpreted to include both statutory and non-statutory material, then the claim must be amended to allow only statutory interpretations.

Claim Rejections - 35 USC § 103

- 5. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 6. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under

Art Unit: 2123

37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

- 7. Claims 1 7, 13 14, 16 23, 27 34 and 38 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yook (Jong-Kwan Yook et al.; "Computation of Switching Noise in Printed Circuit Boards", 1997, IEEE Transactions on Components, Packaging, and Manufacturing Technology, Part A, Volume 20, Number 1, March 1997) in view of Harada (U.S. Patent Number 6,557,154).
 - a. The art of Yook is directed to computation of switching noise in printed circuit boards (*page 64, Title*).
 - b. The art of Harada is directed to analysis of the electromagnetic characteristics of a printed circuit board (*Abstract*).
 - c. The art of Yook and the art of Harada are analogous art because they are both directed to the analysis of electromagnetic characteristics of a printed circuit board.
 - d. Regarding claims 1, 17, 28:
 - e. Yook appears to teach:
 - f. a power supply pair extraction processing section that extracts, if two power supply islands existing in two different power supply layers, respectively, overlap each other, said two power supply islands as a power supply pair (page 68, figure 3; page 67, left-side column, last paragraph, and right-side column, second paragraph that starts with, "For PCB's having . . ."; the limitation would have been obvious in view of the knowledge of the ordinary artisan as described in the references listed in the Conclusion section of this Office Action);

Art Unit: 2123

Page 5

- g. a node layout processing section that positions plural nodes on a power supply pair region which is occupied by each power supply pair on a plane of said circuit board (page 67, left-side column, section A. Tiling Procedure, first paragraph);
- h. a node region determination processing section that determines node regions surrounding said nodes, respectively (page 67, left-side column, section A. Tiling Procedure, first paragraph);
- i. an impedance parameter determination processing section that determines impedance parameters expressing relationships between said nodes, respectively (pages 67 69, section B. Equivalent Circuits; and page 66, figure 2);
- j. a power supply layer model generation processing section that connects said nodes to each other using said impedance parameters, to generate a power supply layer model (page 66, figure 2, PCB Lumped Electrical Ckt Model; page 68, figure 3, circuits displayed in the lower right corner and upper right corner);
- k. a power supply noise analysis model generation processing section that connects said power supply layer model, said lead pattern data and said via pattern data to one another to generate a power supply noise analysis model (page 66, figure 2, PCB Lumped Electrical Ckt Model; page 68, figure 3, circuits displayed in the lower right corner and upper right corner; page 68, right-side column, section 2)

 Power/Signal/Ground Tiles, teaches lead pattern data; page 64, right-side column, second paragraph that starts with, "The goal of . .",

 "PCB tile models are subsequently combined with models for chip current drivers and package leads to produce an electrical simulation model";

 page 67, section A. Tiling Procedure, first paragraph; page 69, section 3) Power/Ground Pin Tiles, first paragraph; page 66, left-side column, last paragraph, first sentence);

1. Yook does not specifically teach:

m. a CAD data obtaining section that obtains CAD data including information concerning a board shape, pattern shapes, and elements;

Art Unit: 2123

n. a CAD data conversion processing section that converts said CAD data into power supply island pattern data, element data, lead pattern data, and via pattern data;

o. Harada appears to teach:

- p. a CAD data obtaining section that obtains CAD data including information concerning a board shape, pattern shapes, and elements (<u>figure 34</u>, <u>block labeled "CAD for layout of PCB"</u>; and <u>figure 33</u>; and <u>column 4</u>, <u>lines 6 17</u>);
- q. a CAD data conversion processing section that converts said CAD data into power supply island pattern data, element data, lead pattern data, and via pattern data (figure 34, block labeled "CAD for layout of PCB"; and figure 33; and column 4, lines 6 17; since the input information about ICs is used to build a circuit model, it would have been obvious that data conversion is performed that converts CAD data into power supply island pattern data, element data, lead pattern data, and via pattern data);
- r. The motivation to use the art of Harada with the art of Yook would have been the benefit recited in Harada that the invention is a PCB design method that reduces radiation of electromagnetic waves by optimizing layout of a substrate (*Abstract, first sentence*), which would have been recognized as a benefit by the ordinary artisan.
- s. Therefore, as discussed above, it would have been obvious to the ordinary artisan at the time of invention to use the art of Harada with the art of Yook to produce the claimed invention.
- t. Regarding claims 16, 27, 38:
- u. Yook appears to teach:

Art Unit: 2123

V. a power supply pair extraction processing section that extracts, as a power supply pair, different two power supply layers overlapping each other in a layering direction from data indicative of said circuit

Page 7

board (page 68, figure 3; page 67, left-side column, last paragraph, and right-side column, second paragraph that starts with, "For PCB's

<u>having . . ."</u>);

W. a power supply noise analysis model generation processing section that uses said power supply pair extracted to generate a power supply noise analysis model (page 66, figure 2, PCB Lumped Electrical Ckt Model; page 68, figure 3, circuits displayed in the lower right corner and upper right corner; page 68, right-side column, section 2)

Power/Signal/Ground Tiles, teaches lead pattern data; page 64, right-side column, second paragraph that starts with, "The goal of . . .",

"PCB tile models are subsequently combined with models for chip current drivers and package leads to produce an electrical simulation model";

page 67, section A. Tiling Procedure, first paragraph; page 69, section 3) Power/Ground Pin Tiles, first paragraph; page 66, left-side column; last paragraph, first sentence);

x. Yook does not specifically teach (in *bold italic underline*):

y. a power supply pair extraction processing section that extracts, as a power supply pair, different two power supply layers overlapping each other in a layering direction <u>from data indicative of said circuit</u> board;

z. Harada appears to teach:

aa. data indicative of said circuit board (figure 34, block labeled "CAD
for layout of PCB"; and figure 33; and column 4, lines 6 - 17);

bb. Therefore, as discussed above, it would have been obvious to the ordinary artisan at the time of invention to use the art of Harada with the art of Yook to produce the claimed invention.

Art Unit: 2123

cc. Regarding claims 2, 18, 29:

dd. Yook appears to teach:

ee. said impedance parameters are a reactance L, a resistance R, and an interlayer capacitance C (page 68, figure 3, circuit diagram in the upper right corner with L, C and R elements).

Page 8

ff. Regarding claims 3, 19, 30:

gg. Yook appears to teach:

hh.wherein if a power supply pair space sandwiched between power supplies of an observed power supply pair is contacted or overlapped by another power supply pair space of any other power supply pair, said power supply pair extraction processing section makes said observed power supply pair and said other power supply pair into a group (page 68, figure 3, the models in the lower half of the figure; it would have been obvious to group overlapping planes).

ii. Regarding claims 4, 20, 31:

jj. Yook does not specifically teach:

kk.a ripple processing section that positions, on said power supply pair region, ripples which are wave fronts of electromagnetic waves radiated into said power supply pair region from said elements, wherein said node layout processing section positions said nodes, based on pitches of said ripples.

Il. Harada appears to teach:

mm. a ripple processing section that positions, on said power supply pair region, ripples which are wave fronts of electromagnetic waves radiated into said power supply pair region from said elements, wherein said node layout processing section positions said nodes, based on pitches of said ripples ($\underline{column\ 15}$, $\underline{lines\ 34\ -\ 67}$, $\underline{and\ column\ 16}$, $\underline{lines\ 1\ -\ 67}$).

nn. Regarding claims 5, 21, 32:

Art Unit: 2123

oo. Yook does not specifically teach:

pp.said ripple processing section uses rising or failing times of those of said elements which are mounted on said power supply pair region, maximum operating frequencies of those elements, and areas of said ripples, to calculate intervals between said ripples.

qq. Harada appears to teach:

rr. said ripple processing section uses rising or failing times of those of said elements which are mounted on said power supply pair region, maximum operating frequencies of those elements, and areas of said ripples, to calculate intervals between said ripples ($\underline{column\ 15}$, $\underline{lines}\ 34-67$, and $\underline{column\ 16}$, $\underline{lines\ 1-67}$).

ss. Regarding claims 6, 22, 33:

tt. Yook does not specifically teach:

uu.said ripple processing section spreads said ripples into power supply pair regions of power supply pairs which belong to a group. vv.Harada appears to teach:

WW. said ripple processing section spreads said ripples into power supply pair regions of power supply pairs which belong to a group (\underline{column} 15, \underline{lines} 34 - 67, and \underline{column} 16, \underline{lines} 1 - 67).

xx. Regarding claim 7, 23, 34:

yy. Yook does not specifically teach:

ZZ. a ripple display processing section that searches for outline coordinates of said ripples, and displays said ripples with the use of said outline coordinates.

aaa. Harada appears to teach:

bbb. a ripple display processing section that searches for outline coordinates of said ripples, and displays said ripples with the use of said outline coordinates (<u>figure 23</u>, <u>element 65</u>).

Page 9

Art Unit: 2123

ccc. Regarding claim 13:

ddd. Yook appears to teach:

eee. said impedance parameter determination processing section determines a reactance L based on distances between said nodes, and determines an interlayer capacitance C with the use of the areas of said node regions and a distance or distances between power supply layers, and said power supply layer model generation processing section arranges said reactance L and said resistance R between nodes on an upper surface of each power supply pair and between nodes on a lower surface of each power supply pair, and arranges each interlayer capacitance C between such a couple of nodes that are arranged at equal positions respectively on the upper and lower surfaces of said power supply pair (page 68, figure 3; and page 68, left-side column, equations 6, 7, 8).

fff. Yook does not specifically teach (in bold underline italic):

ggg. said impedance parameter determination processing section determines a reactance L <u>and a resistance R</u> based on distances between said nodes, and determines an interlayer capacitance C with the use of the areas of said node regions and a distance or distances between power supply layers, and said power supply layer model generation processing section arranges said reactance L and said resistance R between nodes on an upper surface of each power supply pair and between nodes on a lower surface of each power supply pair, and arranges each interlayer capacitance C between such a couple of nodes that are arranged at equal positions respectively on the upper and lower surfaces of said power supply pair.

hhh. Harada appears to teach:

iii. said impedance parameter determination processing section determines \underline{a} resistance \underline{R} based on distances between said nodes (\underline{column} 18, \underline{lines} $\underline{1}$ - 14).

jjj. Regarding claim 14:

Art Unit: 2123

kkk. Yook appears to teach:

Ill. a power supply noise analysis model storage that stores said power supply noise analysis model (page 66, figure 2; since the method is implemented on a computer, it would have been obvious that the PCB Lumped Electrical Ckt Model was stored in storage).

- 8. Claims 8 10, 24 26, 35 37 and 15 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yook as modified by Harada as applied to claims 1 7, 13 14, 16 23, 27 34 and 38 above, and further in view of Shi (Hao Shi et al.; "Modeling Multilayered PCB Power-Bus Designs Using an MPIE Based Circuit Extraction Technique", August 1998, IEEE International Symposium on Electromagnetic Compatibility, pages 647 651).
 - a. Yook as modified by Harada teaches a power supply noise analysis model, as recited in claims 1 7, 13 14, 16 23, 27 34 and 38 above.
 - b. The art of Shi is directed to generating a SPICE model of a PCB and integrating it with IC device models and PCB trace models (*page 651, section Conclusion*).
 - c. The art of Shi and the art of Yook as modified by Harada are analogous art because they are both directed to the analysis of electromagnetic characteristics of a printed circuit board.
 - d. Regarding claims 8, 24, 35:
 - e. Yook as modified by Harada does not specifically teach:
 - f. a mesh division processing section that divides said power supply pair region with the use of meshes based on a wavelength of one of said elements mounted that has the highest operating frequency.
 - g. Shi appears to teach:

Art Unit: 2123

h. a mesh division processing section that divides said power supply pair region with the use of meshes based on a wavelength of one of said elements mounted that has the highest operating frequency (page 647, section III. PCB power-bus analysis using CEMPIE, second paragraph, an upper frequency is used to determine the mesh size).

- i. The motivation to use the art of Shi with the art of Yook as modified by Harada would have been the advantage recited in Shi that the formulation starts from first principles and incorporates the distributed behavior of the planes, yet does not solve the discretized integral equations, rather, extracts an equivalent circuit model (*page 651, section V. Conclusion*), which would have been recognized as a benefit by the ordinary artisan to save time.
- j. Therefore, as discussed above, it would have been obvious to the ordinary artisan at the time of invention to use the art of Shi with the art of Yook as modified by Harada to produce the claimed invention.

k. Regarding claim 9, 25, 36:

l. Yook as modified by Harada does not specifically teach:

 ${\bf m.}$ an internal data storage which stores information for every of said meshes into a table on which coordinates on said circuit board correspond to addresses.

n. Shi appears to teach:

O. an internal data storage which stores information for every of said meshes into a table on which coordinates on said circuit board correspond to addresses (page 648, figure 1, and Table I; since the meshes are implemented on a computer, it would have been obvious that there was an internal data storage which stores information for every of said meshes into a table on which coordinates on said circuit board correspond to addresses).

p. Regarding claim 10, 26, 37:

Art Unit: 2123

q. Yook as modified by Harada does not specifically teach:

r. the information for every of said meshes includes at least one of a ripple level which indicates the number of ripples from an element to a corresponding mesh, the presence or absence of a node in said corresponding mesh, and a node region identifier expressing a node region to which said corresponding mesh belongs.

s. Shi appears to teach:

t. the information for every of said meshes includes at least a node region identifier expressing a node region to which said corresponding mesh belongs (page 648, figure 1 and figure 2; the node regions are labeled power-bus and power-island, and it would have been obvious that each node had a node region identifier to identify the node region).

u. Regarding claim 15:

v. Yook as modified by Harada does not specifically teach:

W. said power supply noise analysis model generation processing section further generates a total circuit model in which said power supply noise analysis model is connected to said element data, and stores said total circuit model into said power supply noise analysis model storage.

x. Shi appears to teach:

y. said power supply noise analysis model generation processing section further generates a total circuit model in which said power supply noise analysis model is connected to said element data, and stores said total circuit model into said power supply noise analysis model storage (page 651, section V. Conclusion; since the method is implemented in a computer, it would have been obvious that the model was stored for analysis).

Art Unit: 2123

9. Claims 11 - 12 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yook as modified by Harada as applied to claims 1 - 7, 13 - 14, 16 - 23, 27 - 34 and 38 above, and further in view of Papadopoulou (U.S. Patent Number 6,178,539).

- a. Yook as modified by Harada teaches a power supply noise analysis model, as recited in claims 1 7, 13 14, 16 23, 27 34 and 38 above.
- b. The art of Papadopoulou is directed to calculating critical areas of circuit layouts using Voronoi diagrams (*Abstract*).
- c. The art of Papadopoulou and the art of Yook as modified by Harada are analogous art because they are both contain the art of tiling a circuit (*Papadopoulou, Abstract, Voronoi diagram; Yook, page 66, figure 2, tiling processor*).

d. Regarding claims 11:

- e. Yook as modified by Harada does not specifically teach:
- f. wherein, taking a most adjacent node as the node closest to an observed node within a sector having a predetermined radius about said observed node as the center of said sector, said node region determination processing section searches for adjacent nodes by rotating said sector about said observed node.
- g. Papadopoulou appears to teach:
- h. wherein, taking a most adjacent node as the node closest to an observed node within a sector having a predetermined radius about said observed node as the center of said sector, said node region determination processing section searches for adjacent nodes by rotating said sector about said observed node (column 5, lines 19 67, column 6, lines 1 9; it would have been obvious in computing a Voronoi tessellation to search for adjacent nodes by rotating a sector about an observed node).

i. Regarding claim 12:

j. Yook as modified by Harada does not specifically teach:

Art Unit: 2123

k. wherein said node region determination processing section removes a square from said power supply pair region thereby to determine an edge of the node region of said observed node with respect to said most adjacent node, said square having as an edge a perpendicular bisector of a predetermined length between said observed node and said most adjacent node and containing said most adjacent node, so that edges of said node region of said observed node are sequentially determined with respect to all the adjacent nodes, respectively, in the order of increasing distance from said most adjacent node, finally to determine the node region of said observed node.

Page 15.

1. Papadopoulou appears to teach:

m. wherein said node region determination processing section removes a square from said power supply pair region thereby to determine an edge of the node region of said observed node with respect to said most adjacent node, said square having as an edge a perpendicular bisector of a predetermined length between said observed node and said most adjacent node and containing said most adjacent node, so that edges of said node region of said observed node are sequentially determined with respect to all the adjacent nodes, respectively, in the order of increasing distance from said most adjacent node, finally to determine the node region of said observed node (column 5, lines 19 - 67, column 6, lines 1 - 9; it would have been obvious in computing a Voronoi tessellation to perform the limitation).

- n. The motivation to use the art of Papdopoulou with the art of Yook as modified by Harada would have been the benefit recited in Papadopoulou that in particularly useful methods, the step of decomposing each region into shapes is preferably included ($\underbrace{column\ 3, lines\ 5-8}$).
- o. Therefore, as discussed above, it would have been obvious to the ordinary artisan at the time of invention to use the art of Papdopoulou with the art of Yook as modified by Harada to produce the claimed invention.

Art Unit: 2123

10. Examiner's Note: Examiner has cited particular columns and line numbers in the references applied to the claims above for the convenience of the applicant. Although the specified citations are representative of the teachings of the art and are applied to specific limitations within the individual claim, other passages and figures may apply as well. It is respectfully requested from the Applicant in preparing responses, to fully consider the references in their entirety as potentially teaching all or part of the claimed invention, as well as the context of the passage as taught by the prior art or disclosed by the Examiner. The entire reference is considered to provide disclosure relating to the claimed invention.

Art Unit: 2123

Conclusion

Page 17

11. The prior art made of record and not relied upon is considered pertinent to the applicant's disclosure:

- a. Mabuchi (U.S. Patent Application Publication 2003/0109995) teaches generating a SPICE model of a printed circuit board.
- b. Frank Y. Yuan, "Electromagnetic Modeling and Signal Integrity Simulation of Power/Ground Networks in High Speed Digital Packages and Printed Circuit Boards", 1998, Proceedings of the 1998 Design Automation Conference, pages 421 426; teaches power/ground supply networks involve complex, large structures such as combinations of plane/partial planes, and integrating the PCB model with the circuit model.
- c. S. Luan et al.; "Extracting CAD Models for Quantifying Noise Coupling between Vias in PCB Layouts", 28 May 2002, Proceedings of the 52nd Electronic Components and Technology Conference, pages 343 346; teaches extracting printed circuit board parameters from CAD, generating a SPICE model of the printed circuit board, and integrating the board model with the circuit model for analysis.
- d. Albert E. Ruehli et al.; "Progress in the Methodologies for the Electrical Modeling of Interconnects and Electronic Packages", May 2001, Proceedings of the IEEE, Volume 89, Number 5, pages 740 771; teaches extracting CAD data to generate a SPICE model.
- e. Hayashi (U.S. Patent Number 6,842,727) teaches extracting layout data, and generating a SPICE model.
- f. Du Cloux (U.S. Patent Number 5,625,578) teaches meshing a printed circuit board to generate an equivalent circuit.

Art Unit: 2123

Page 18

12. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Russ Guill whose telephone number is 571-272-7955. The examiner can normally be reached on Monday – Friday 9:30 AM – 6:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Paul Rodriguez can be reached on 571-272-3753. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300. Any inquiry of a general nature or relating to the status of this application should be directed to the TC2100 Group Receptionist: 571-272-2100.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

RG

Russ Guill Examiner Art Unit 2123

> PAUL RODRIGUEZ SUPERVISORY PATENT EXAMINER ECHNOLOGY CENTER 2100